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FORM PTO-1449 (Modified)				ATTY DOCKET NO: \$63.2-6259-USO3	Serial No: 10/60001			
		ORMATION DISCLOSUR		APPLICANT: David A. Ferrera et al				
STATEMENT BY APPLICANT (Use several sheets if necessary)				FILING DATE: Not Assigned	Group: N	Group: Not Assign		
REFERI	NCE I	ESIGNATION .	U.S	. PATENT DOCUMENTS				
REFERENCE DESIGNATION U.S. I EXAM'S PATENT NUMBER ISSUE DATE DATE		PATENTEE	CLASS	SUBCLASS	FILING DATE			
&K	AA	5195969	3/23/93	Wang et al	604_	96		
	AB	5330428	7/19/94	Wang	604	96		
	AC	4154244	5/15/79	Becker	128	349		
\top	AD	5556383	9/17/96	. Wang et al	604	96		
\top	AE	5270086	12/14/93	Hamlin	428	35.2		
	AF	RE 32,983	7/11/89	Levy	428	36.92	<u> </u>	
\mathcal{T}	AG	4963313	10/16/90	Noddin et al.	264	573		
	AH	5290306	3/1/94	Trotta et al	606	194	<u></u>	
1	AI	5512051	4/30/96	Wang et al	604	96	<u> </u>	
	ΑJ	5264260	11/23/93	Saab	428	35.5		
8K	AK	RE 33,561	3/26/91	Levy	428	36.92		
	<u> </u>		T DOCUM	ENT OR PUBLISHED FOREIGN PAT	ENT APPLIC	CATION		
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SK	BA	96/04951	2/22/96	wo	A61M	25/00		x_
	BB_	95/22367	8/24/95	wo	A61M	25/00		x .
	вс	0457456	11/21/91	EP	A61M	25/00	<u> </u>	x
	BD	92/19440	11/12/92	wo	B29C	49/00		x
2K	BĖ	0745395	4/12/96	EP	A61L	29/00		x
THER	AR'	I (Including Author, 7	Citle, Date,	Pertinent Pages, Etc.)				
2K				aterials, pp. 3-5. Date unknown.				•
1	СВ	M. Cakmak et al., Pro	ocessing Chara	icteristics, Structure Development, and Proerties of Engineering and Science, vol. 30, no. 12, pp. 721-	f Uni and Biaxia	ally Stretched	Poly(Ethy	lene 2
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INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)					FILING DATE: Not Assigned	GROUP: Not Assigned				
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			OTHER	ART (In	cluding Author, Title, Date, Pertinent Pag	ges, Etc.)				
&K	CA		JAPANESE ABSTRACT, APPLN NO. 03174200, FILED 7/15/91							
&K	СВ		JAPANESE ABSTRACT, APPLN NO. 05088654, FILED 4/15/93							
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&K	AA	5223205	6/29/93	Jackowski et al.	264	521	100,000		
<u>ب.رر</u>	AB	4820349	4/11/89	Saab	128	344			
	AC	5492741	2/20/96	Akao et al.	428	35.2			
	AD	5348538	9/20/94	Wang et al.	604	96			
			4/4/95	Wang et al.	606	194			
	AE	5403340	9/12/95	Fukui et al.	562	486			
	AF	5449820	 		528	272			
	AG	5189140	2/23/93	Nakane et al.		1			
	AH	5,587,125	12/24/96	Roychowdhury	264	515			
014	AI	5500181	3/19/96	Wang et al.	264	532			
SKI	AJ	5330428	7/19/94	Wang et al.	604	96	<u></u>		
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				nance PEN & Naphthalate Based Pack	naina Resins S	hell Chemical C	o April 19	94.	
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&K	CB D2857-70 Standard Method of Test for Dilute-Solution Viscosity of Polymers, 1970 Annual Book of ASTM Standards, Part 27, Pla General Method of Testing, Nomenclature, pp. 713-718.								
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APPLICATION NO.: - 10/600017 ATTY DOCKET NO.: S63.2- 6259-US03 FORM PTO-1449 (Modified) LIST OF PATENTS AND APPLICANT: David A. Ferrera et al. **PUBLICATIONS** FOR APPLICANT'S FILING DATE: Not Assigned GROUP: NA INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary) U.S. PATENT AND PUBLISHED APPLICATION DOCUMENTS REFERENCE DESIGNATION CLASS/ FILING DATE DATE NAME DOCUMENT EXAM'S SUBCLASS IF APPROPRIATE INIT. NUMBER 606/194 5879369 3/9/99 **Ishida** 428/35.2 6/5/01 Ferrera et al. 6242063 ΑB 604/96 Chen АC 5554120 9/10/96 264/521 4/19/94 Downey 5304340 AD 604/96 Saab 6004289 12/21/99 Chen et al. 525/92 1/11/00 6013728 AF 2/16/99 Kramer et al. 604/96 5871468 ΑG 604/27 Bampos et al. 6013055 1/11/00 AH 604/103.06 12/4/01 Schaible et al. 6325780 ΑI 604/103.06 Ferrera et al. 6358227 3/19/02 FOREIGN PATENT DOCUMENTS COUNTRY DOCUMENT DATE NUMBER BA OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.) JP abstract of patent number 2509016; publication number 05-15603. JP abstract of patent number 2975803; publication number 06/296693. СВ SK 04 EXAMINER 🔬 DATE CONSIDERED EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not

considered. Include copy of this form with next communication to applicant.